Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
09/225,189	QIAN, RICHARD J.	
Examiner	Art Unit	
James M. Hannett	2612	

	SEARCHED				
Class	Subclass	Date	Examiner		
348	586	5/24/2005	JMH		
348	239	5/24/2005	JMH		
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INTERFERENCE SEARCHED					
Class	Subclass Date		Examiner		
348	586	5/24/2005	ЈМН		
348	239	5/24/2005	ЈМН		

SEA (INCLUDING	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
		DATE	EXMR
East		5/24/2005	ЈМН
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